Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/765,729	PARKER ET AL.
Examiner	Art Unit

3744

Chen-Wen Jiang

SEARCHED			
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Class	Subclass	Date	Examiner
62	296		
415	220		
	221 .		
416	243		
	183		
	185		
	223	2/17/2006	CJ

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	1	<u> </u>		

SEARCH (INCLUDING SEA		SY)
	DATE	EXMR
EAST Searched Inventor Searched	2/17/2006	cJ